

Express Mail No.

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: Walter SCHWARZENBACH et al. Confirmation No.

Application No.: **Group Art Unit:**

Filing Date: Examiner:

For: METHOD OF MAKING CAVITIES IN A SEMICONDUCTOR WAFER Atty. Docket No.: 4717-9200

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450

Sir:

Pursuant to applicants' duty of disclosure under 37 C.F.R. 1.56, enclosed are copies of nine (9) references for the Examiner's review and consideration. These references are listed on the enclosed Form PTO-1449.

These references were cited in the European Search Report a copy of which is enclosed. It is respectfully requested that these references be made of record in this application by the Examiner's completion and return of the PTO Form 1449.

No fee or certification is believed to be due for this submission since the references are being submitted concurrent with the filing of this application. Should any fees be required, however, please charge such fees to **Winston & Strawn** Deposit Account No. 50-1814.

Respectfully submitted,

Allan A. Fanucci (Reg. No. 30,256)

**WINSTON & STRAWN LLP
CUSTOMER NO. 28765
(212) 294-3311**

Enclosures

LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>		ATTY. DOCKET NO.:	APPLICATION NO.:
		4717-9200	
		APPLICANT:	
		Walter SCHWARZENBACH et al.	
		FILING DATE:	GROUP:

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	4,956,314	9/1990	Tam et al.	437	241	
	AB	5,576,250	11/1996	Diem et al.	437	228	
	AC	5,780,885	7/1998	Diem et al.	257	254	
	AD	5,976,945	11/1999	Chi et al.	438	386	
	AE	6,171,923 B1	1/2001	Chi et al.	438	386	
	AF	6,335,292 B1	1/2002	Li et al.	438	714	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AG	2 700 065 (with English Abstract)	7/1994	France			X	
	AH	2 795 554 (with English Abstract)	12/2000	France			X	
	AI	JP 06132262 (with English Abstract)	5/1994	Japan			X	
	AJ							
	AK							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AL	
	AM	
	AN	

EXAMINER	DATE CONSIDERED
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.